

Notice of References Cited	Application/Control No. 10/777,009	Applicant(s)/Patent Under Reexamination XU ET AL.	
	Examiner David L. Vanik	Art Unit 1615	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0124083	07-2003	Filipski et al.	424/73
*	B	US-5,587,156	12-1996	Wdowik, Mark S.	424/73
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	M	US-			

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*	N	WO 02/87519	11-2002	WO Documnet	Dodd et al.	A61K 7/00
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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